Search Notes



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Applicant(s)/Patent Under Reexamination

TAKAYAMA ET AL.

Examiner

Art Unit

ERNESTO GARCIA

3679

SEARCHED

Class	Subclass	Date	Examiner
403	24, 26	1/11/10	EG
428	546, 548, 567, 569, 615, 660, 663, 674,675, 676, 677	1/11/10	EG
	Updated Above	9/7/2010	VLM

SF	ΔR	CH	ΙN	വ	TES
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Search Notes	Date	Examiner
Consulted Michael Lavilla for class 428	1/11/10	EG

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

/E. G./ Examiner.Art Unit 3679

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